## Improved Sublinear Algorithms for Testing Permutation Freeness



Ordered Patterns in Arrays
array $A$ of length $n$

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A has a $\pi$-appearance if $\exists$ indices $i_{1}<i_{2}<\ldots<i_{k}$ such that

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A\left[i_{a}\right]>A\left[i_{b}\right] \quad \text { if } \pi(a)>\pi(b) \quad \forall a, b \in[k]
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$A$ is $\pi$-free if it has no $\pi$-appearance

Examples

| 100 | 98 | 723 | 1.2 | 5.88 |
| :--- | :--- | :--- | :--- | :--- |

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$$
\begin{array}{ll} 
& (3,1,2)-\text { appearance } \\
& (3,4,1,2) \text { - appearance } \\
& (2,3,1) \text { - appearance }
\end{array}
$$

Problem
Given array $A$, permutation $\pi$Is $A \pi$-free?Is A $\varepsilon$-far from $\pi$-free?

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Hamming distance of $A$ to every $\pi$-free array is $\geqslant \varepsilon n$
Given array $A$, permutation $\pi$
Is $A \pi$-free?Is $A \varepsilon$-far from $\pi$-free? $\varepsilon \in(0,1)$

Problem
Hamming distance of $A$ to every $\pi$-free array is $\geqslant \varepsilon n$
Given array $A$, permutation $\pi$
I\& $A \pi$-free?
Is $A$-far from $\pi$-free?
Generalization of monotonicity testing on arrays
[EKKRVOO, DGLRRP99,... PRVI8]

HistoryInitiated by [NRRS'19]

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$$
(1,2, \ldots, k) \text { or }(k, k-1, \ldots, 2,1)
$$

[NRRS'19, BCLW'19, BL W'19]

Highlights
OPTIMAL
$O(\log n)$ - query tester for monotone patterns of constant length [BLW'Iq]

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$O(\log n)$-query tester for monotone patterns of constant length
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polylog $n$ query tester for arbitrary patterns of length 3
[NRRS'19]

$$
1234665 \cdots 10
$$

Highlights
$O(\log n)$-query tester for monotone patterns of constant length
[BLW'19]
polylog $n$ query tester for arbitrary patterns of length 3 [NRRS'19]
What about nonmonotone patterns of length $>3$ ?Nonadaptive testers $O\left(n^{1-\frac{1}{k-1}}\right)$ queries [NRRS '19]Nonadaptive testers $O\left(n^{1-\frac{1}{k-1}}\right)$ queries [MRS' 19$]$

- Nonadaptive testers cannot do better! [ $\left.B C^{\prime} 18\right]$Nonadaptive testers $O\left(n^{1-\frac{1}{k-1}}\right)$ queries [NRRS'19]
- Nonadaptive testers cannot do better!

$$
[B C \cdot 18]
$$

What about adaptive testers?

Our Result
Let $\varepsilon \in(0,1), k \in \mathbb{N}$ and $\pi \in S_{k}$.
There is an $\varepsilon$-tester for $\pi$-freeness with query complexity $\tilde{O}\left(n^{\circ(1)}\right)$.

Our Result
Let $\varepsilon \in(0,1), k \in \mathbb{N}$ and $\pi \in S_{k}$.
There is an $\varepsilon$-tester for $\pi$-freeness with query complexity $\tilde{O}\left(n^{0(1)}\right)$.

The tester has one-sided error. always accepts $\pi$-free arrays

Features of our resultStrong sublinear-time guarantee

Features of our resultStrong sublinear-time guaranteeOur techniques are general and work for all $\pi$

Today: $\tilde{O}(\sqrt{n})$-query algorithm for testing $\pi$-freeness of $\pi \in S_{4}$
$\longrightarrow$ every $n \cdot a$. algo. for this problem has q.C.

$$
\Omega\left(n^{2 / 3}\right)
$$

Today: $\tilde{O}(\sqrt{n})$-query algorithm for testing $\pi$-freeness of $\pi \in S_{4}$
$\left\{\begin{array}{l}\text { Find a } \pi \text {-appearance in an } \\ \text { array that is } \varepsilon \text {-far from } \\ \pi \text {-free }\end{array}\right.$

First Useful Fact
Array $A$ is $\varepsilon$-far from $\pi$-free $\Rightarrow$

Matching of $\pi$-appearances of size $\geqslant \frac{\varepsilon_{n}}{4}$

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First Useful Fact algorithms to test $\pi$-freeness
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Eg. (100), (99) 78,98$) 77,97,76,21$

Key Ingredient
View the array as a grid of $n$ points in $[n] \times \mathbb{R}$


Grid of Points
Our algorithm makes use of an $m \times m$ partition of the main grid.


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Gridding
Determine layers so that each layer has $\sim \frac{n}{m}$ points

Partition [ $n$ ] into $m$ stripes of $\tilde{O}(m)$ queries $\frac{n}{m}$ indices

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Determine layers so that each layer has $\sim \frac{n}{m}$ points

Partition [n] into $m$ stripes of


Set $m \leftarrow \sqrt{n}$
$\tilde{O}(m)$ queries

Boxes in the grid


Boxes in the grid


Boxes in the grid
Next Goal: Determine the distribution of points among the boxes by sampling


Gridding: Part 2

From each stripe, sample $\tilde{0}(1)^{-1} \log ^{100}$ points \& mark
 the boxes with at least one sampled point

Gridding: Part 2

From each stripe, sample $\tilde{O}$ (1) points \& mark the boxes with at least one sampled point


There are $m^{2}$ boxes, out of which we mark $\tilde{O}(m)$ boxes only

Marcus - Tardos Helps Us
Lemma [M T'O4]: For any $\pi \in S_{k}, \exists a$ constant $K(K)$ such that for any $r \in \mathbb{N}$, if grid $G_{r, r}$ has $\geqslant K(k) \cdot r$ marked cells, then there is a $\pi$-appearance among the cells.

Gridding: Part 2
From each stripe, sample $\tilde{O}$ (1) points \& mark the boxes with at least one sampled point
Reject if $\pi$-appearance found


Suppose $\pi=(3,2,1,4)$
There is a $\pi$-appearance among marked boxes

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Suppose $\pi=(3,2,1,4)$
There is a $\pi$-appearance among marked boxes

After marking boxes
If there are more than $K(4) \cdot m$ marked boxes, we are done! $\rightarrow$ imm. detect a T- app.
Assume we have $\leqslant K_{1}(4) \cdot m$ marked boxes

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Can we ignore the unmarked boxes?

After marking boxes
Lemma : With high probability, for each stripe $S$

- either has $\tilde{\Omega}(1)$ marked boxes

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$\Omega(n) \quad$ either has $\tilde{\Omega}(1)$ marked boxes

- or union of marked boxes contain $(1-0(1)) \cdot|S|$ points $\}$

$O(1) \cdot|S|$
$0(1) \cdot x$

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OK to ignore unmarked boxes!

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Ignore points in such layers \& stripes

After Gridding
$m \times m$ grid with $O(m)$ dense boxes

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There is a matching of $\pi$-appearances of size $\Omega(\varepsilon n)$ among dense boxes

After Gridding
$m \times m$ grid with $O(m)$ dense boxes
Each layer/stripe has $\leqslant d$ dense boxes
There is a matching of $\pi$-appearances of size $\Omega\left(\varepsilon_{n}\right)$

Where in the grid do these appear?

If Gridding step did not reject...
Most $\pi$-appearances have more than one leg in boxes that share a stripe or layer

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Different types of $\pi$-appearances
Configuration: Arrangement of $\leqslant 4$ boxes and a mapping of legs of $\pi$-appearance into themTwo boxes $B, B^{\prime}$ in a configuration are directly-connected if they share a layer or a stripe

Connected components in configuration
Transitive closure of directly-connected relation is the connected relation


How to detect these?

Only constantly many distinct types of configurations


How to detect these?: High-level Schema
for each configuration
Detect a $\pi$-appearance among dense boxes forming the configuration

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$\Omega\left(\varepsilon_{n}\right) \pi$-appearances have all four legs in a single dense box


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Algorithm: Sample a random dense box and query all points in it

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Algorithm: Sample a random dense box and query all points in it

Case La: $\Omega(\varepsilon n) \pi$-appearances are present as


Case Ia: $\Omega(\varepsilon n) \pi$-appearances are present as
 1-component configurationEach dense box belongs to $O\left(d^{3}\right)$ "copies" of such box-arrangements in grid <d
$\square$
$\square$

$$
\leq d
$$

Case La: $\Omega(\varepsilon n) \pi$-appearances are present as


1-component configurationEach dense box belongs to $O\left(d^{3}\right)$ "copies" of such box-arrangements in gridA random dense box participates in $\Omega(n / m)$ such appearances

Case La: $\Omega(\varepsilon n) \pi$-appearances are present as
Sample a uniformly random dense box $B$ and query all points in all copies of 1-component configurations involving $B$

Case Ia: $\Omega(\varepsilon n) \pi$-appearances are present as

O
$O(\sqrt{n})$


1-component configurationSample a uniformly random dense box $B$ and query all points in all copies of 1-component configurations involving $B$

Case $2: \Omega\left(\varepsilon_{n}\right) \pi$-appearances in

$$
\begin{array}{ccc}
3 \square & & \square^{4} \\
& \square^{2} \square_{1}^{\square}
\end{array}
$$

Case $2: \Omega(\varepsilon n) \pi$-appearances in
for each pair of dense boxes sharing a layer:

* Test ( 1,2 )-freeness \& $(2,1)$-freeness

Solving a more general problem

- Detect a $\nu$-appearance with a specific leg mapping, where $\nu$ is a subpattern of $\pi$

Many more ideas needed
Reducing the complexity to $n^{0(1)}$

Generalizing to larger patterns

Open Problems

- True complexity of testing $\pi$-freeness

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- What about patterns of super constant length?
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Thank You!

